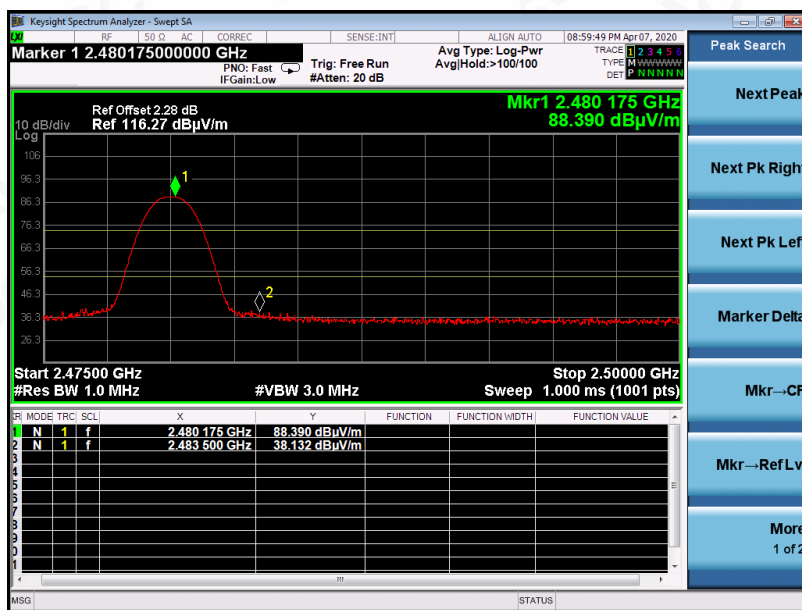


EUT	LinearFlux Headphones	Model Name	Hypersonic
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 9	Antenna	Horizontal

PK



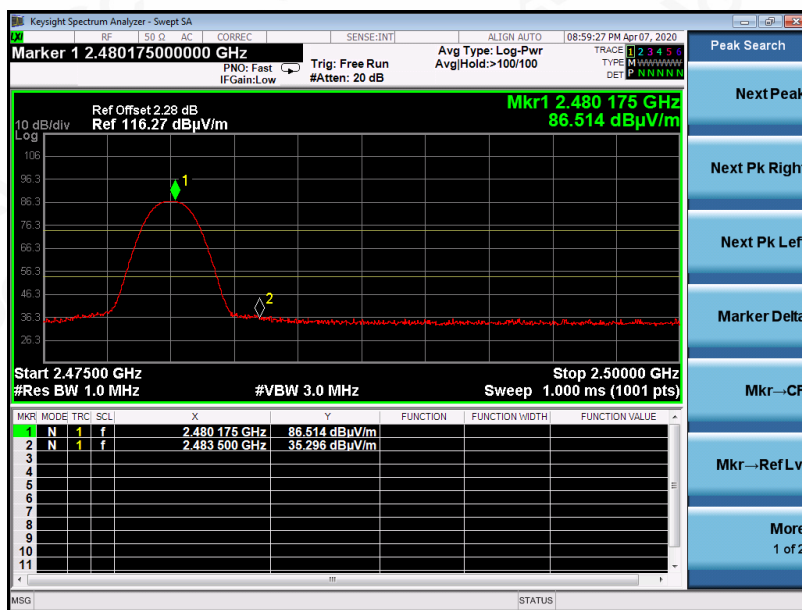
AV



RESULT: PASS

EUT	LinearFlux Headphones	Model Name	Hypersonic
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 9	Antenna	Vertical

PK



AV



RESULT: PASS

Note: The factor had been edited in the "Input Correction" of the Spectrum Analyzer. So the Amplitude of test plots is equal to Reading level plus the Factor in dB. Use the A dB(μV) to represent the Amplitude. Use the F dB(μV/m) to represent the Field Strength. So A=F. All test modes had been pre-tested. The 8DPSK modulation is the worst case and recorded in the report.

11. NUMBER OF HOPPING FREQUENCY

11.1. MEASUREMENT PROCEDURE

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen.
2. RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.
3. VBW $\geq$ RBW. Sweep: Auto. Detector function: Peak. Trace: Max hold.
4. Allow the trace to stabilize.

11.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)

Same as described in section 8.2

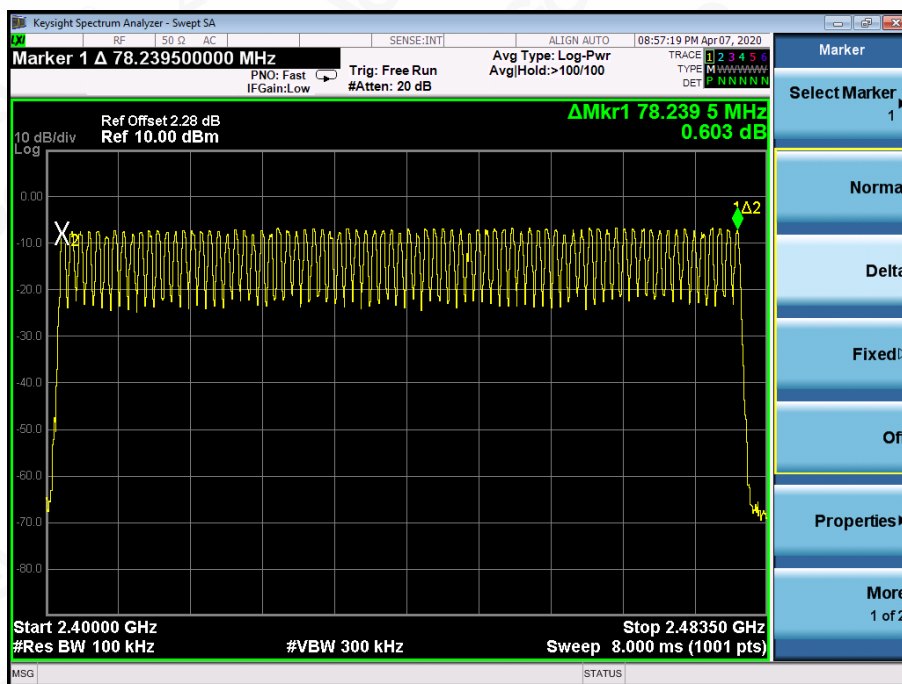
11.3. MEASUREMENT EQUIPMENT USED

The same as described in section 6

11.4. LIMITS AND MEASUREMENT RESULT

TOTAL NO. OF HOPPING CHANNEL	LIMIT (NO. OF CH)	MEASUREMENT (NO. OF CH)	RESULT
	≥ 15	79	PASS

TEST PLOT FOR NO. OF TOTAL CHANNELS



Note: The GFSK modulation is the worst case and recorded in the report.

12. TIME OF OCCUPANCY (DWELL TIME)

12.1. MEASUREMENT PROCEDURE

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span: Zero span, centered on a hopping channel.
2. RBW shall be $\leq$ channel spacing and where possible RBW should be set $\gg 1/T$, where T is the expected dwell time per channel.
3. Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel.
4. Detector function: Peak. Trace: Max hold.
5. Use the marker-delta function to determine the transmit time per hop.
6. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation:

(Number of hops in the period specified in the requirements) = (number of hops on spectrum analyzer) $\times$ (period specified in the requirements / analyzer sweep time)

7. The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements.

12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)

Same as described in section 8.2

12.3. MEASUREMENT EQUIPMENT USED

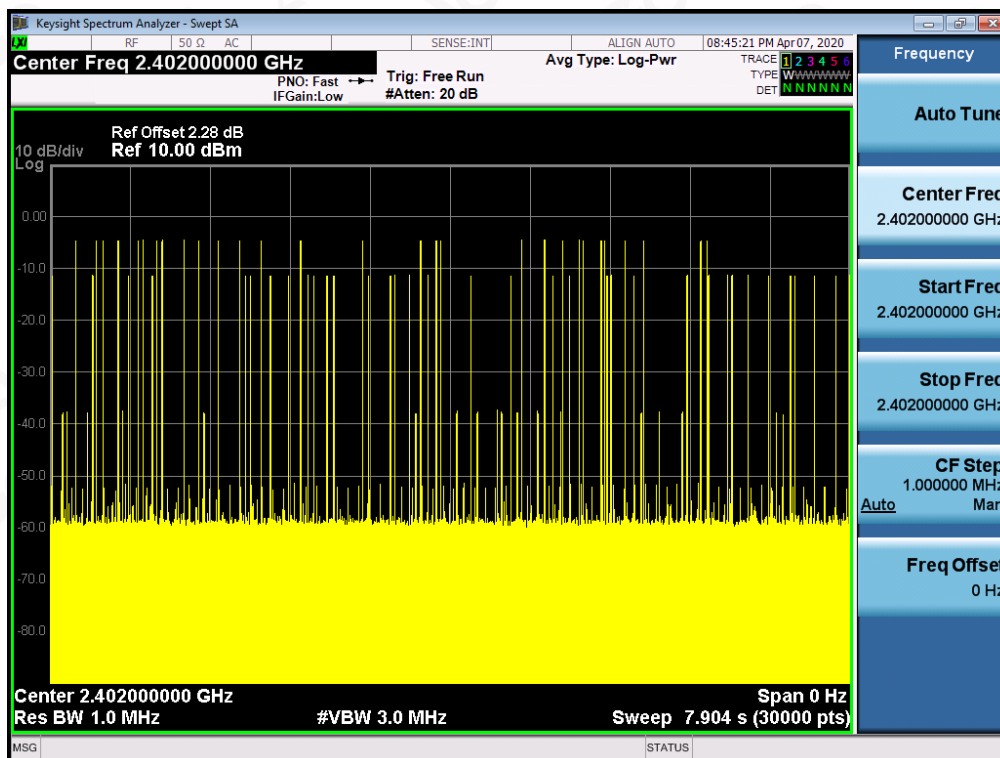
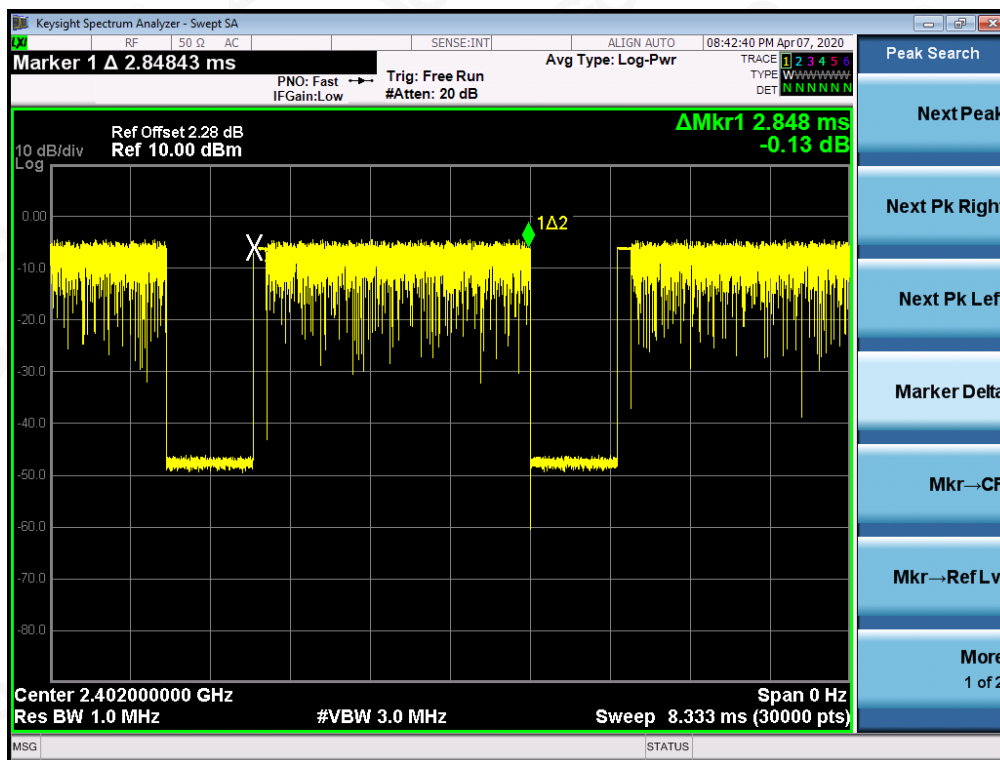
The same as described in section 6

12.4. LIMITS AND MEASUREMENT RESULT

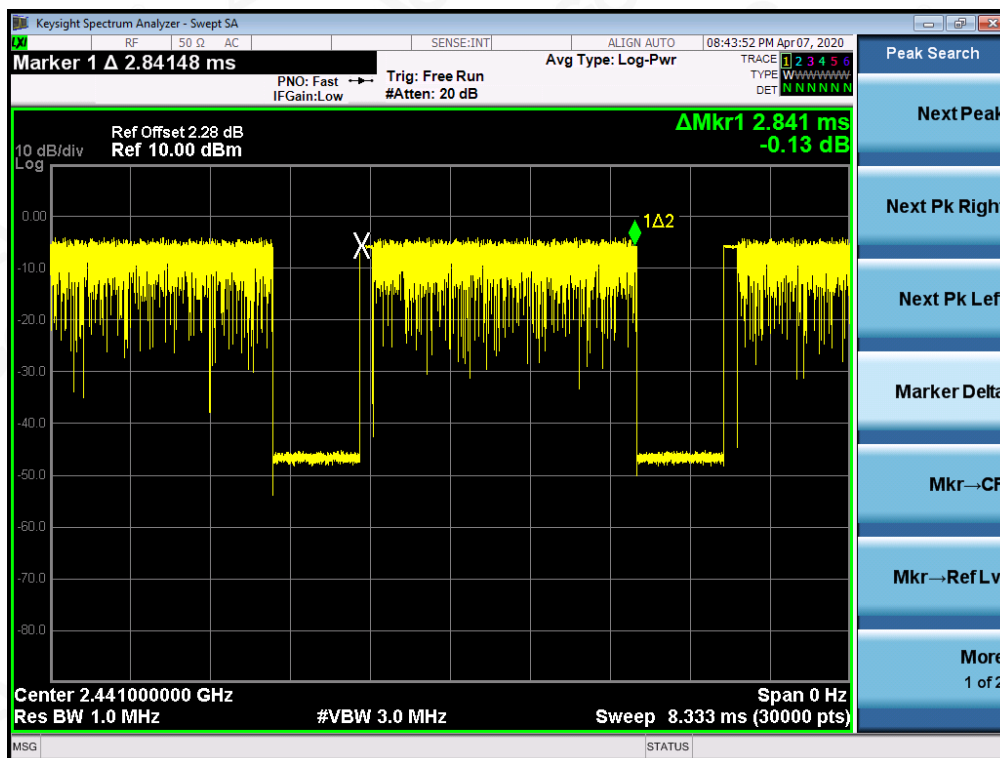
Channel	Time of Pulse for DH5 (ms)	Number of hops in the period specified in the requirements	Sweep Time (ms)	Limit (ms)
Low	2.848	29*4	330.368	400
Middle	2.841	26*4	295.464	400
High	2.864	27*4	309.312	400

Note: The 8DPSK modulation is the worst case and recorded in the report.

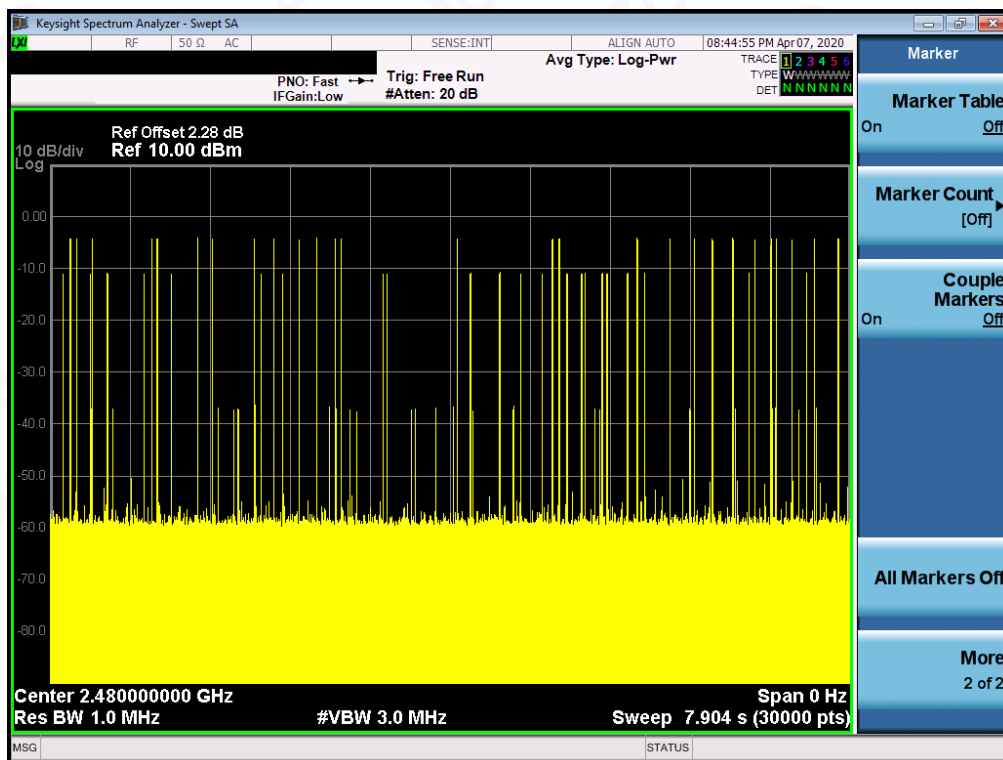
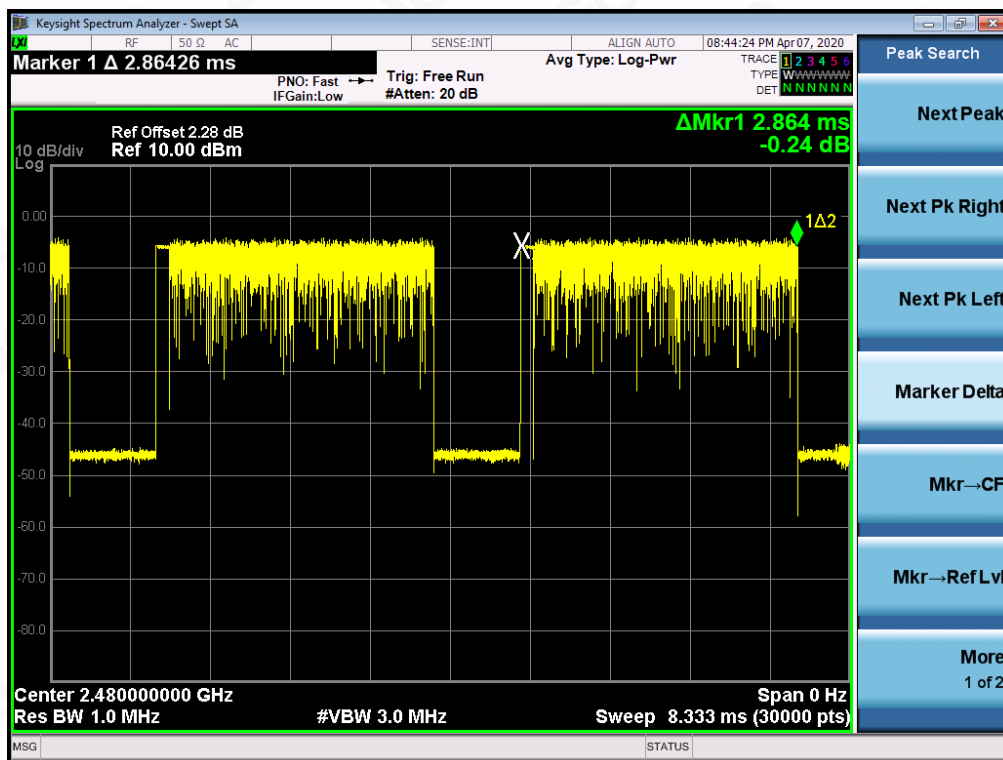
TEST PLOT OF LOW CHANNEL



TEST PLOT OF MIDDLE CHANNEL



TEST PLOT OF HIGH CHANNEL



13. FREQUENCY SEPARATION

13.1. MEASUREMENT PROCEDURE

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span: Wide enough to capture the peaks of two adjacent channels.
 2. RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.
 3. Video (or average) bandwidth (VBW) $\geq$ RBW.
 4. Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize.
- Use the marker-delta function to determine the separation between the peaks of the adjacent channels.

13.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)

Same as described in section 6.2

13.3. MEASUREMENT EQUIPMENT USED

The same as described in section 6.3

13.4. LIMITS AND MEASUREMENT RESULT

CHANNEL	CHANNEL SEPARATION KHz	LIMIT (KHz)	RESULT
CH01-CH02	990	≥ 25 KHz or 2/3 20 dB BW	PASS

TEST PLOT FOR FREQUENCY SEPARATION



Note: The 8DPSK modulation is the worst case and recorded in the report.

14. FCC LINE CONDUCTED EMISSION TEST

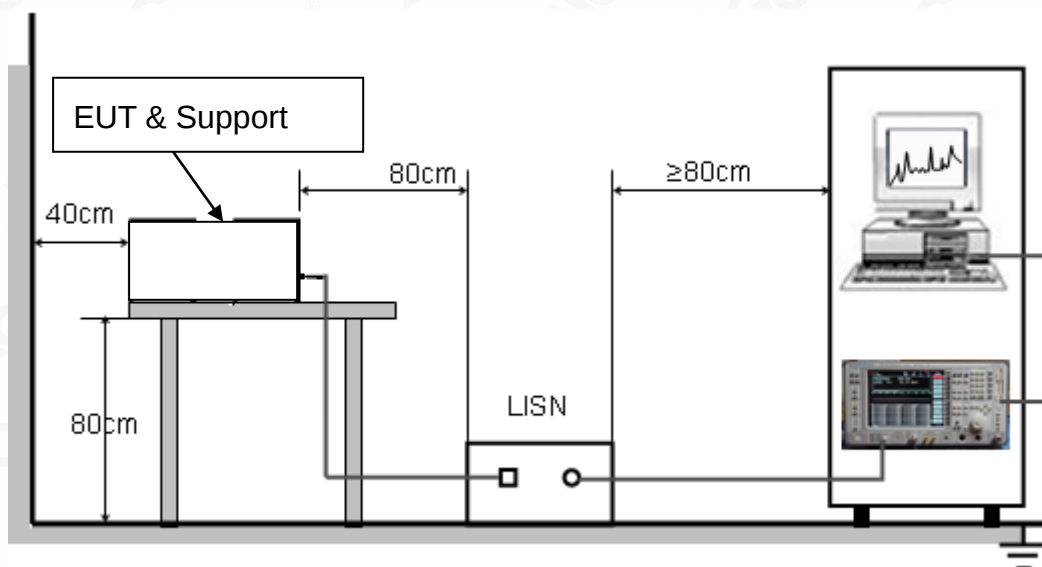
14.1. LIMITS OF LINE CONDUCTED EMISSION TEST

Frequency	Maximum RF Line Voltage	
	Q.P.(dBuV)	Average(dBuV)
150kHz~500kHz	66-56	56-46
500kHz~5MHz	56	46
5MHz~30MHz	60	50

Note: 1. The lower limit shall apply at the transition frequency.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

14.2. BLOCK DIAGRAM OF LINE CONDUCTED EMISSION TEST



14.3. PRELIMINARY PROCEDURE OF LINE CONDUCTED EMISSION TEST

1. The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
2. Support equipment, if needed, was placed as per ANSI C63.10.
3. All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10.
4. All support equipments received AC120V/60Hz power from a LISN, if any.
5. The EUT received DC charging voltage by adapter which received AC120V/60Hz power by a LISN.
6. The test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
7. Analyzer / Receiver scanned from 150 kHz to 30MHz for emissions in each of the test modes.
8. During the above scans, the emissions were maximized by cable manipulation.
9. The test mode(s) were scanned during the preliminary test.

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.

14.4. FINAL PROCEDURE OF LINE CONDUCTED EMISSION TEST

1. EUT and support equipment was set up on the test bench as per step 2 of the preliminary test.
2. A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less -2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using Q.P and Average detector.
3. The test data of the worst case condition(s) was reported on the Summary Data page.

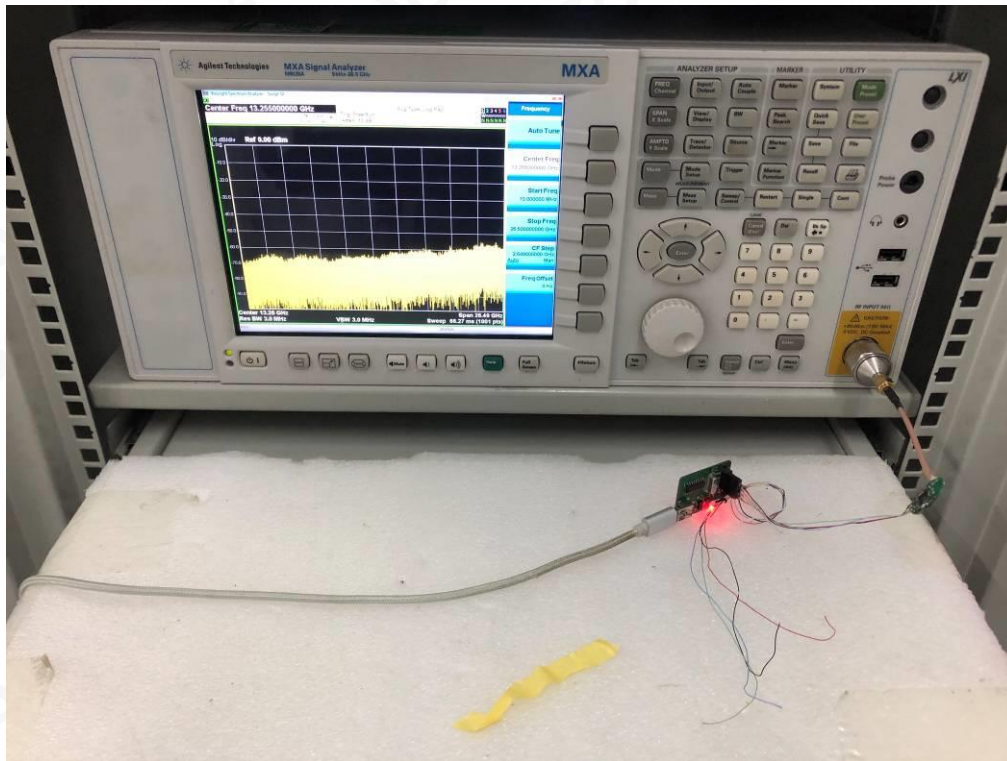
14.5. TEST RESULT OF LINE CONDUCTED EMISSION TEST

N/A

Note: The EUT can not use the BT function with charging.

APPENDIX A: PHOTOGRAPHS OF TEST SETUP**RADIATED EMISSION TEST SETUP BELOW 1GHZ****RADIATED EMISSION TEST SETUP ABOVE 1GHZ**

CONDUCTED TEST SETUP



Attestation of Global Compliance

Attestation of Global Compliance(Shenzhen)Co.,Ltd.

Add: 2/F., Building 2, Sanwei Chaxi Industrial Park, Sanwei Community,
Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China

Tel: +86-755 2523 4088

E-mail: agc@agc-cert.com

Service Hotline: 400 089 2118

APPENDIX B: PHOTOGRAPHS OF EUT

TOTAL VIEW OF EUT



Headset

TOP VIEW OF EUT



Attestation of Global Compliance

Attestation of Global Compliance(Shenzhen)Co.,Ltd.

Add: 2/F., Building 2, Sanwei Chaxi Industrial Park, Sanwei Community,
Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China

Tel: +86-755 2523 4088

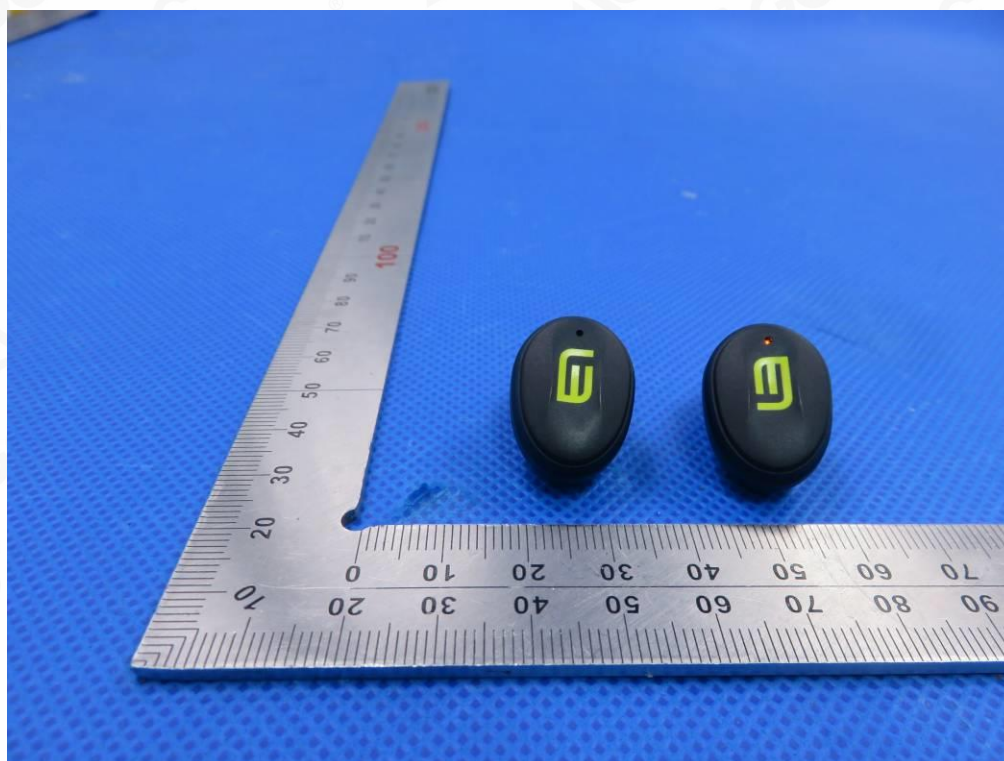
E-mail: agc@agc-cert.com

Service Hotline: 400 089 2118

BOTTOM VIEW OF EUT



FRONT VIEW OF EUT



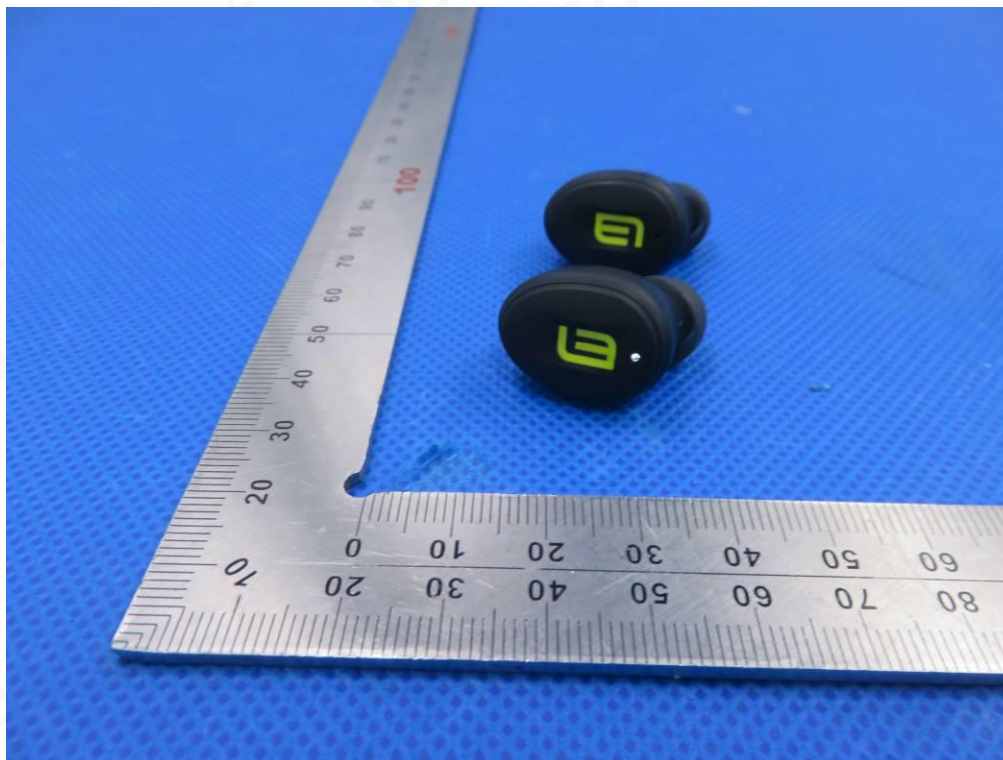
BACK VIEW OF EUT



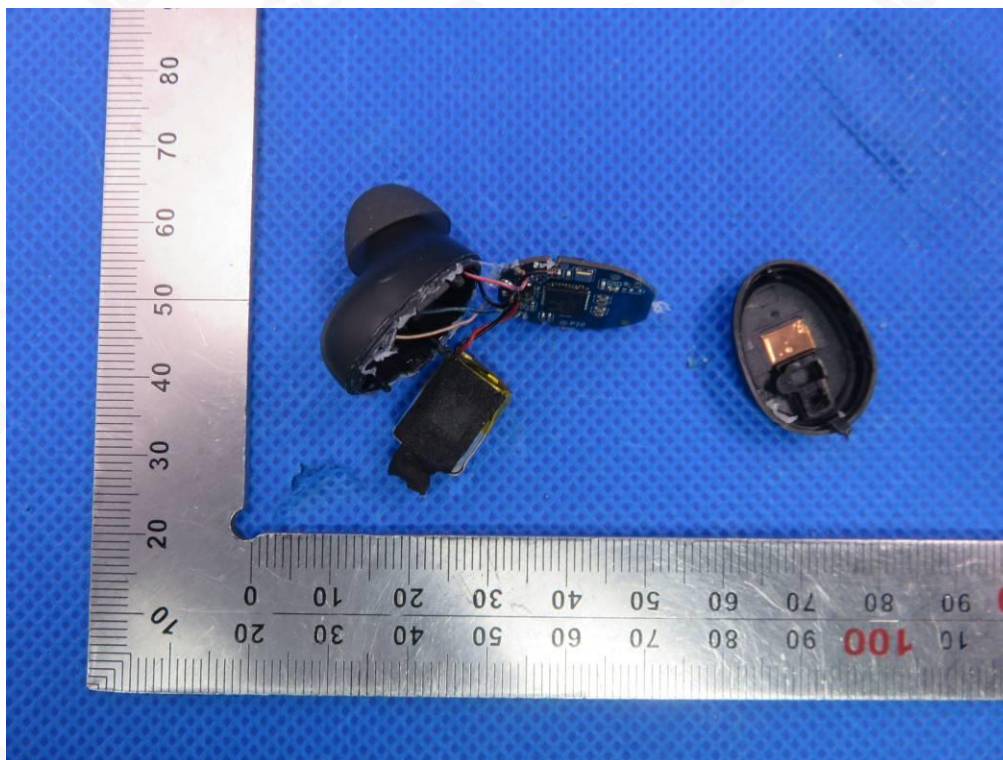
LEFT VIEW OF EUT



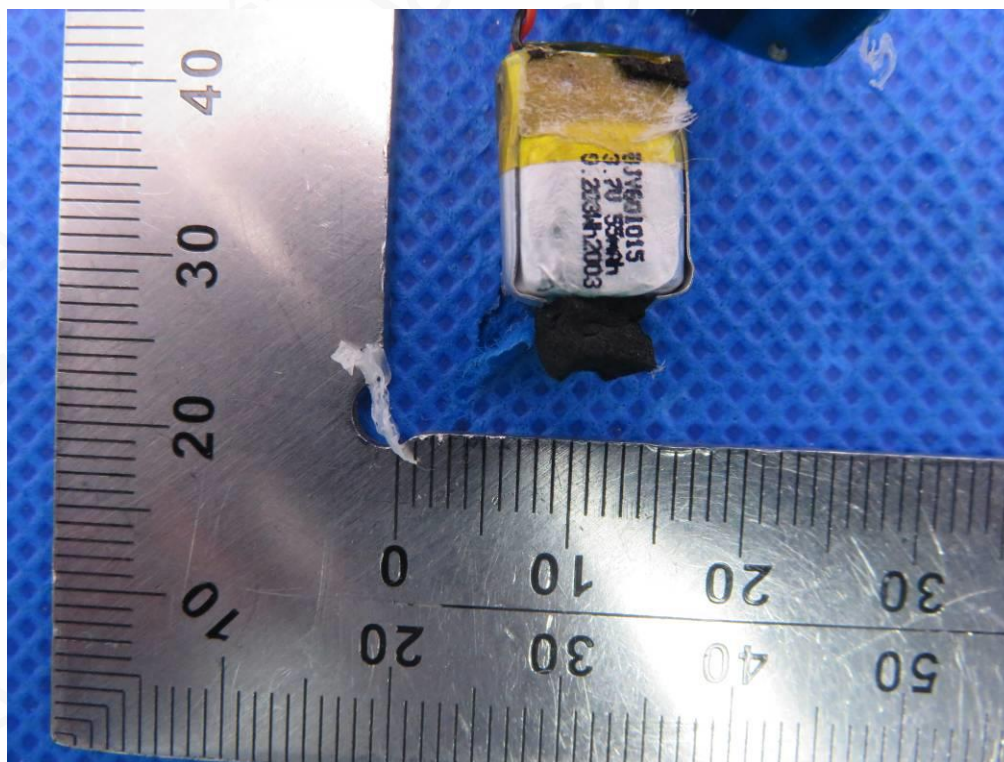
RIGHT VIEW OF EUT



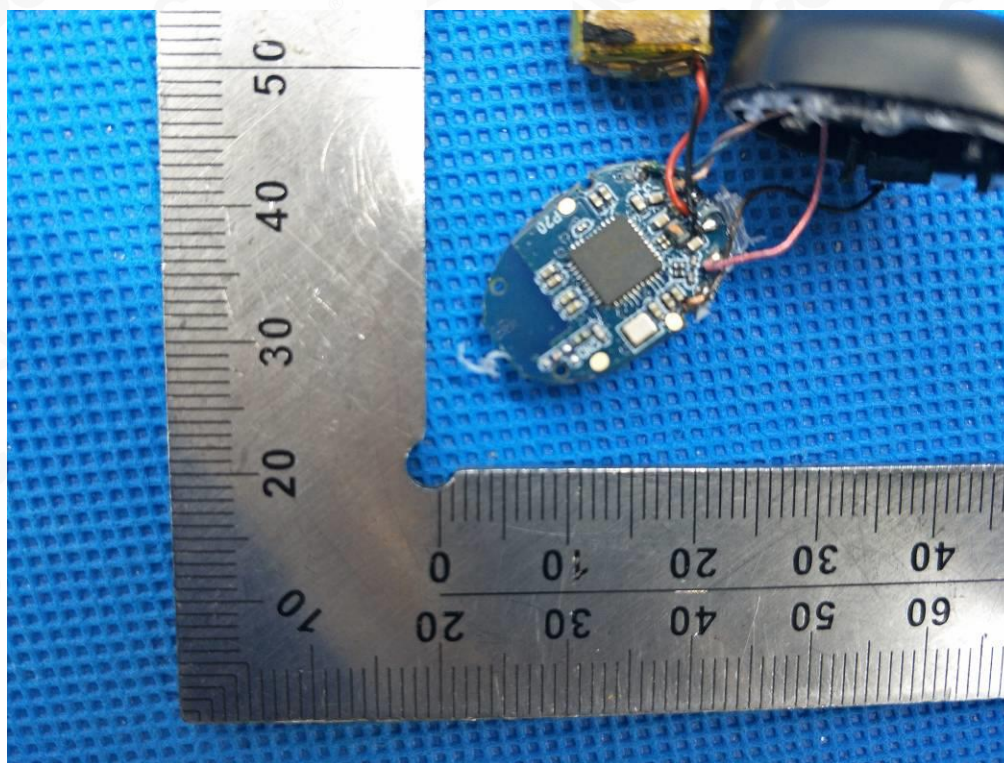
Left
OPEN VIEW OF EUT



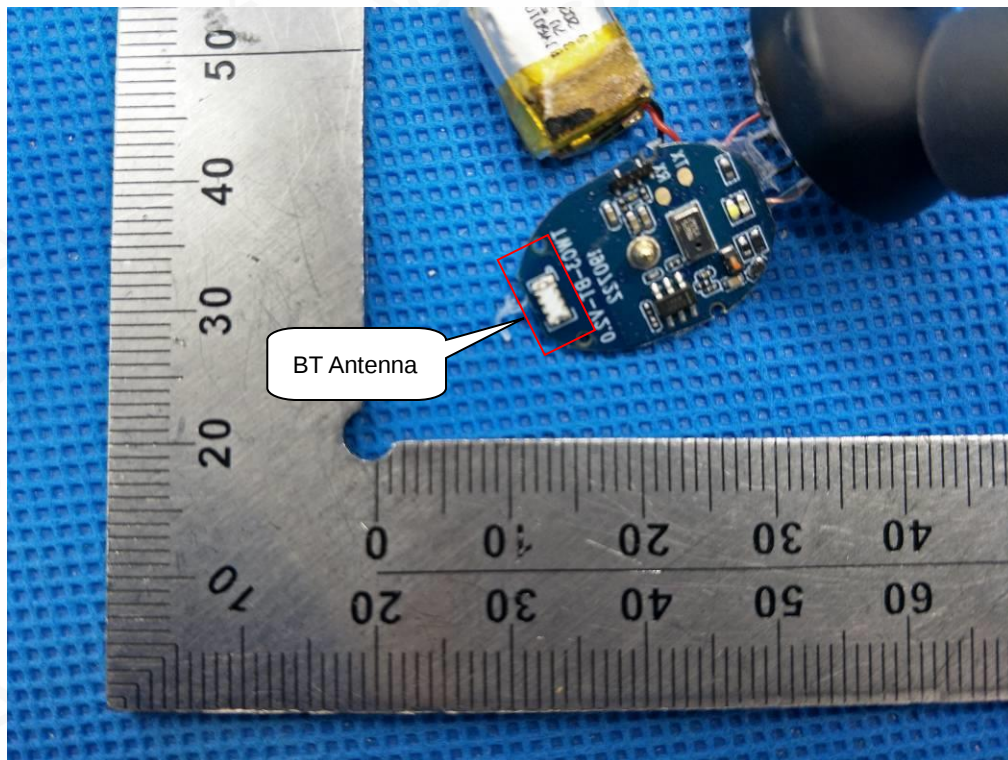
VIEW OF BATTERY



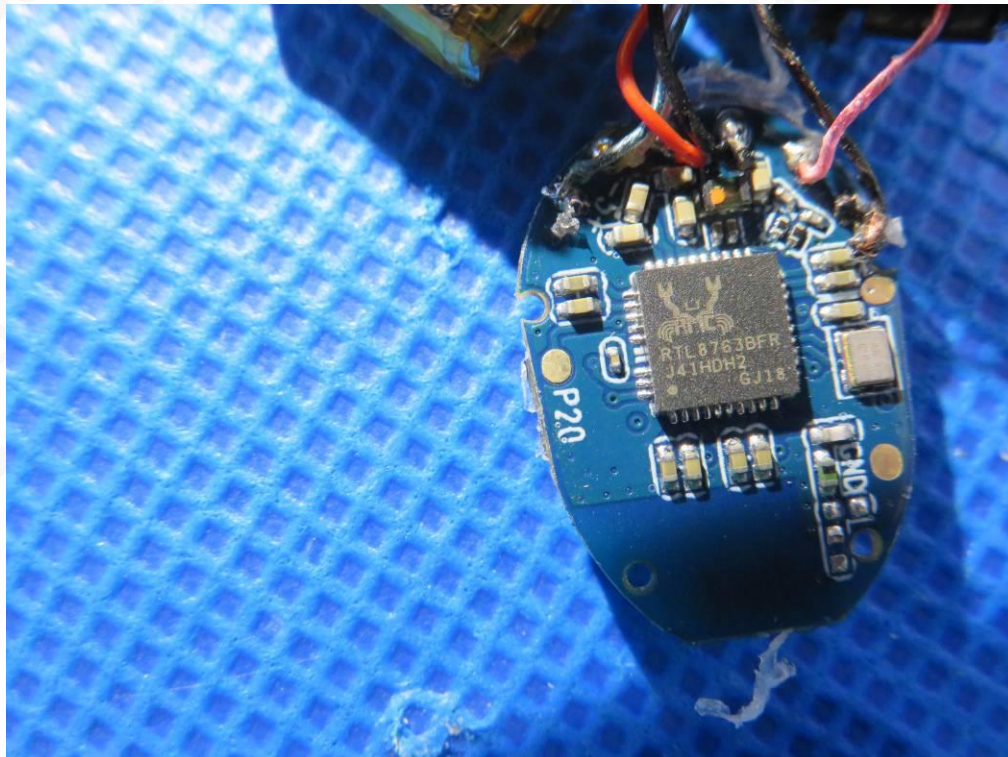
INTERNAL VIEW OF EUT-1



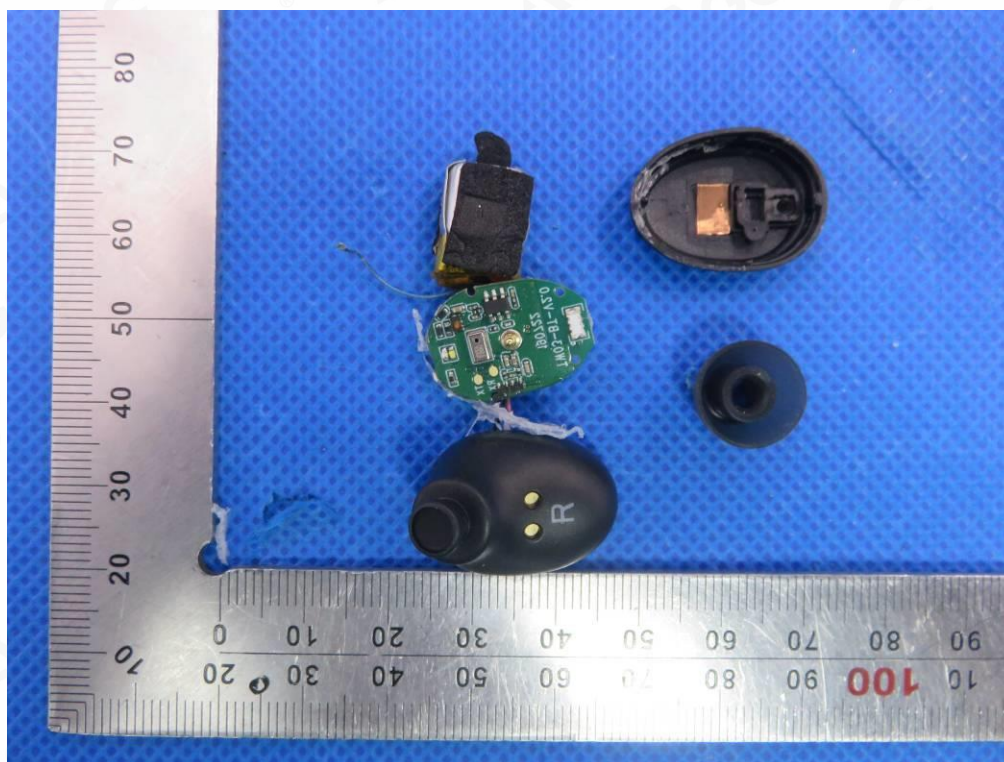
INTERNAL VIEW OF EUT-2



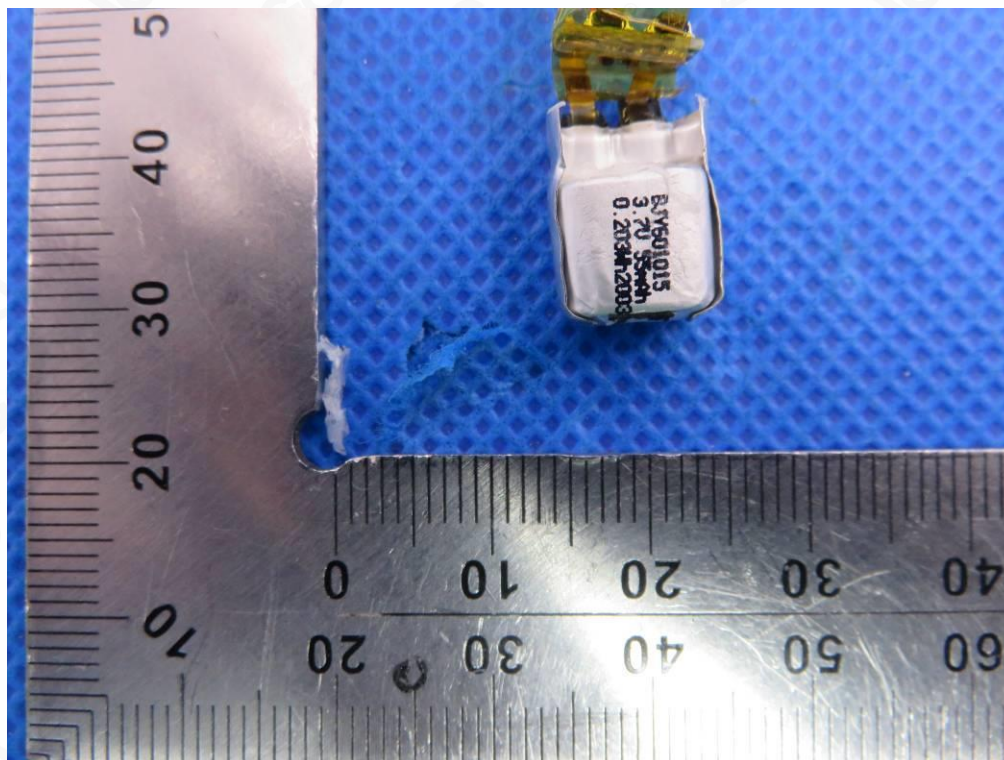
INTERNAL VIEW OF EUT-3



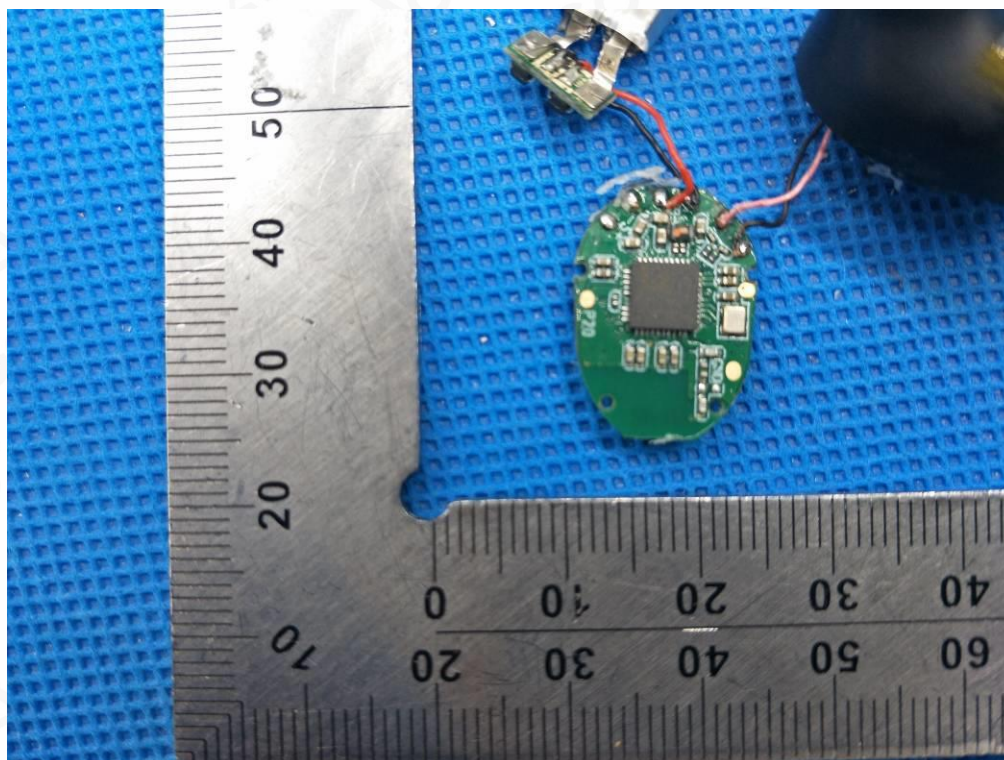
Right
OPEN VIEW OF EUT



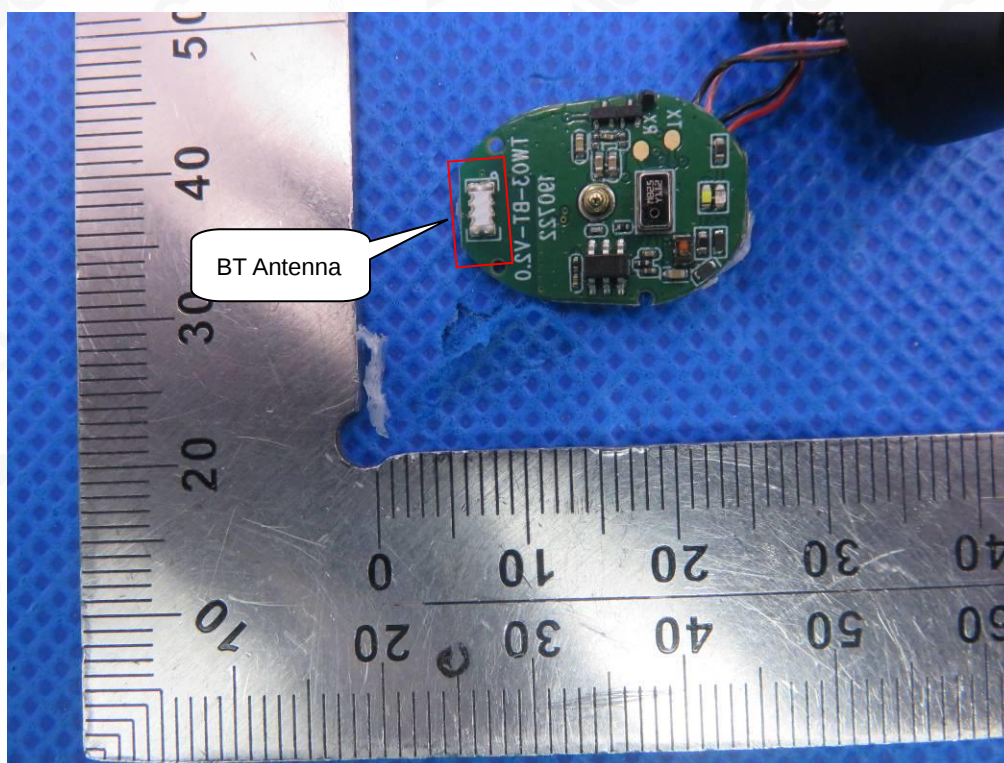
VIEW OF BATTERY



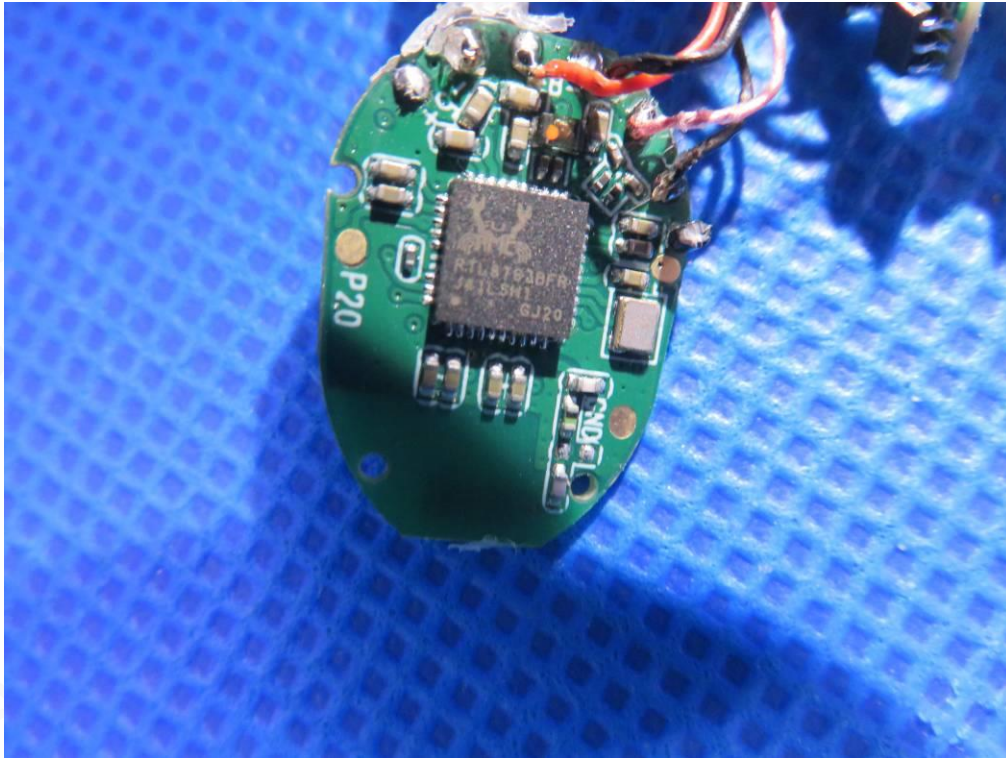
INTERNAL VIEW OF EUT-1



INTERNAL VIEW OF EUT-2



INTERNAL VIEW OF EUT-3



Charging Dock

VIEW OF EUT (port)-1



VIEW OF EUT (port)-2



----END OF REPORT----



Attestation of Global Compliance

Attestation of Global Compliance(Shenzhen)Co.,Ltd.

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